



## DESCRIPTION

AM7401 is the P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior, fast switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency load switching applications.

AM74001 is available in a DFN8(3.3x3.3) package.

## ORDERING INFORMATION

Package Type	Part Number	
DFN8(3.3x3.3) SPQ: 3,000pcs/Reel	J8	AM7401J8R
		AM7401J8VR
Note	V: Halogen free Package R: Tape & Reel	
AiT provides all RoHS products		

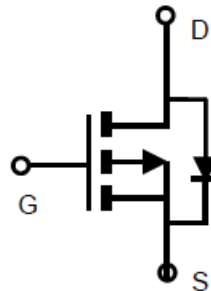
## FEATURES

- $V_{DS} = -30V$ ,  $I_D = -39A$   
 $R_{DS(ON)} = 10.5m\Omega(Typ.) @ V_{GS} = -10V$   
 $R_{DS(ON)} = 14m\Omega(Typ.) @ V_{GS} = -4.5V$
- 100% UIS and Rg tested
- Available in a DFN8(3.3x3.3) package.

## APPLICATION

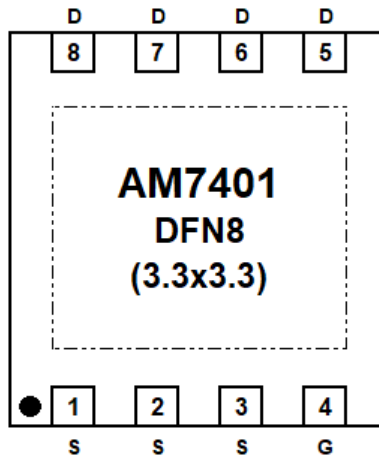
- LED Application
- Power Management
- Load switch

## PIN DESCRIPTION





## PIN DESCRIPTION



Top View

Pin #	Symbol	Function
1	S	Source
2	S	Source
3	S	Source
4	G	Gate
5	D	Drain
6	D	Drain
7	D	Drain
8	D	Drain



## ABSOLUTE MAXIMUM RATINGS

T<sub>A</sub> = 25°C, unless otherwise noted

V <sub>DSS</sub> , Drain-Source Voltage		-30V
V <sub>GSS</sub> , Gate-Source Voltage		±25V
I <sub>D</sub> , Continuous Drain Current	T <sub>C</sub> =25°C	-39A
	T <sub>C</sub> =100°C	-24.7A
I <sub>DM</sub> , Pulsed Drain Current <sup>NOTE1</sup>		-156A
I <sub>D</sub> , Continuous Drain Current	T <sub>A</sub> =25°C	-12.3A
	T <sub>A</sub> =70°C	-10A
P <sub>D</sub> , Power Dissipation <sup>NOTE2</sup>	T <sub>A</sub> =25°C	3.1W
	T <sub>A</sub> =70°C	2W
I <sub>AS</sub> , Avalanche Current <sup>NOTE1</sup>		-30A
E <sub>AS</sub> , Single Pulse Avalanche energy L=0.1mH <sup>NOTE1,6</sup>		45mJ
P <sub>D</sub> , Power Dissipation <sup>NOTE3</sup>	T <sub>C</sub> =25°C	31.3W
	T <sub>C</sub> =100°C	12.5W
T <sub>J</sub> , Operation Junction Temperature		-55°C~+150°C
T <sub>STG</sub> , Storage Temperature Range		-55°C~+150°C

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## THERMAL CHARACTERISTICS

Parameter		Symbol	Limit	Units
Thermal Resistance Junction to Ambient <sup>NOTE2</sup>	t ≤ 10s	R <sub>θJA</sub>	40	°C/W
Thermal Resistance Junction to Ambient <sup>NOTE2,4</sup>	Steady-State		60	
Thermal Resistance Junction to Case			R <sub>θJC</sub>	4



## ELECTRICAL CHARACTERISTICS

T<sub>A</sub> = 25°C, unless otherwise noted

Parameter	Symbol	Conditions	Min	Typ.	Max	Units
<b>Static Parameters</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	-30	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-1	-1.6	-2.5	V
Gate Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±25V	-	-	±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V T <sub>J</sub> =25°C	-	-	-1	μA
		V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V T <sub>J</sub> =75°C	-	-	-10	
Drain-source On-Resistance <sup>NOTE5</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = -10V, I <sub>D</sub> = -12.3A	-	10.5	13	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -10A	-	14	18	
Forward Transconductance	G <sub>FS</sub>	V <sub>DS</sub> = -10V, I <sub>D</sub> = -10A	-	12.5	-	S
<b>Diode Characteristics</b>						
Diode Forward Voltage <sup>NOTE5</sup>	V <sub>SD</sub>	I <sub>S</sub> = -1A, V <sub>GS</sub> = 0V	-	-0.7	-1	V
Continuous Source Current	I <sub>S</sub>		-	-	-39	A
Reverse Recovery Time	t <sub>rr</sub>	I <sub>S</sub> = -10A,	-	13.8	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	di/dt = 100A/μs	-	12.3	-	nC
<b>Dynamic and Switching Parameters</b>						
Total Gate Charge(10V)	Q <sub>g</sub>	V <sub>DS</sub> = -15V, V <sub>GS</sub> = -10V, I <sub>D</sub> = -10A	-	36	48.6	nC
Total Gate Charge(4.5V)	Q <sub>g</sub>		-	18	24.3	
Gate-Source Charge	Q <sub>gs</sub>		-	8.1	10.9	
Gate-Drain Charge	Q <sub>gd</sub>		-	11.5	15.5	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V, f = 1MHz	-	2590	-	pF
Output Capacitance	C <sub>oss</sub>		-	283	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	172	-	
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V, f = 1MHz	-	8.8	-	Ω
Turn-On Time <sup>NOTE5</sup>	t <sub>d(on)</sub>	V <sub>DD</sub> = -15V, V <sub>GEN</sub> = -10V, R <sub>G</sub> = 3Ω, I <sub>D</sub> = -1A	-	19.1	36	ns
	t <sub>r</sub>		-	4.8	9	
Turn-Off Time <sup>NOTE5</sup>	t <sub>d(off)</sub>		-	58	110	
	t <sub>f</sub>		-	11.5	22	

NOTE1: Pulsed width limited by maximum junction temperature, T<sub>J(MAX)</sub> = 150°C.

NOTE2: Measure the value in a still air environment at T<sub>A</sub> = 25°C, using an installation mounted on a 1 in<sup>2</sup> FR-4 board, maximum junction temperature T<sub>J(MAX)</sub> = 150°C.

NOTE3: Using junction-to-case thermal resistance, dissipation limit in the case of additional heat.

NOTE4: T<sub>J(MAX)</sub> = 150°C, using junction-to-case thermal resistance (R<sub>θJC</sub>) is more useful in additional heat sinking is used.

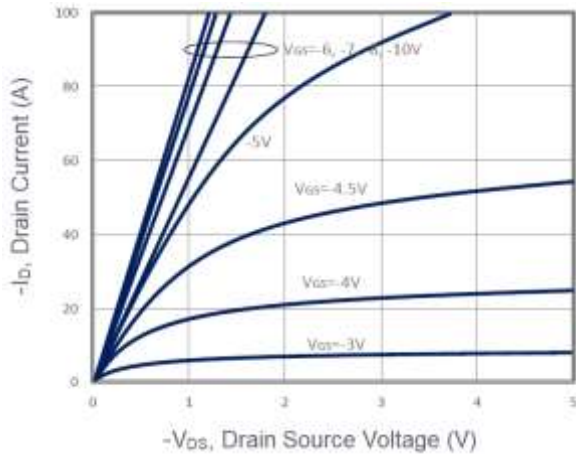
NOTE5: The pulse test width is ≤ 300μs and the duty cycle ≤ 2%.

NOTE6: The E<sub>AS</sub> data shows Maximum, tested and pulse width limited by maximum.

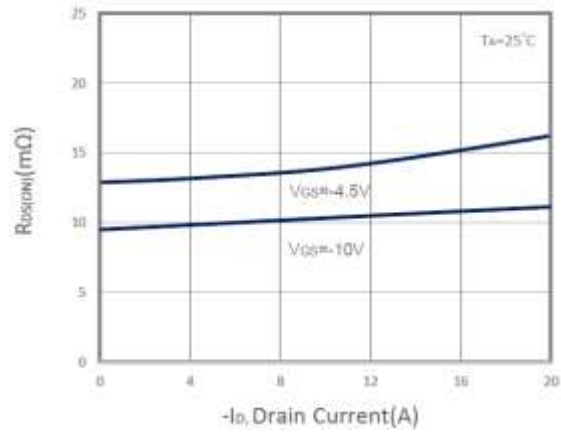


**TYPICAL CHARACTERISTICS**

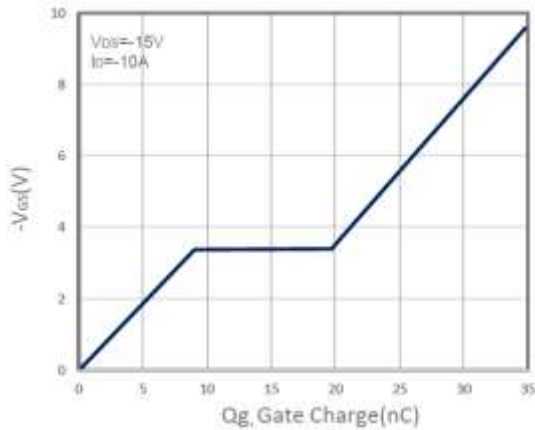
1. Output Characteristics



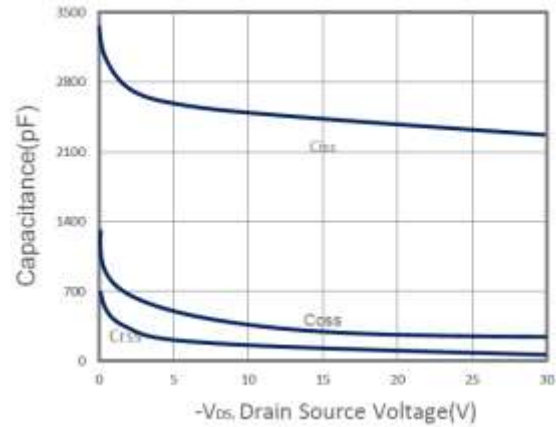
2. Drain-Source On Resistance



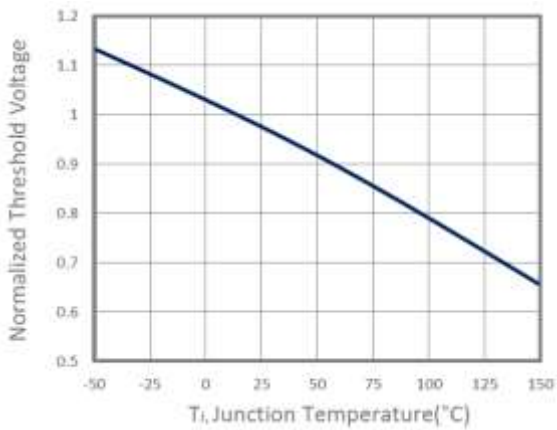
3. Gate Charge



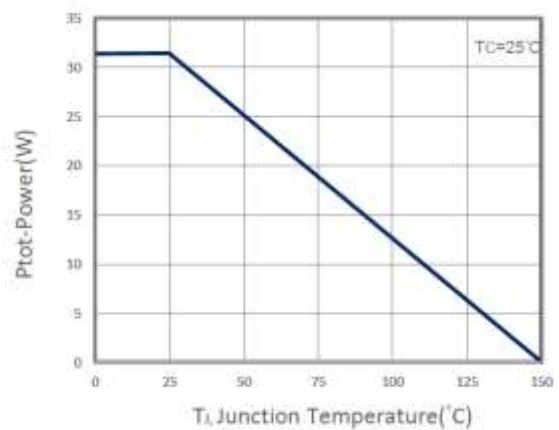
4. Capacitance



5. Gate Threshold Voltage

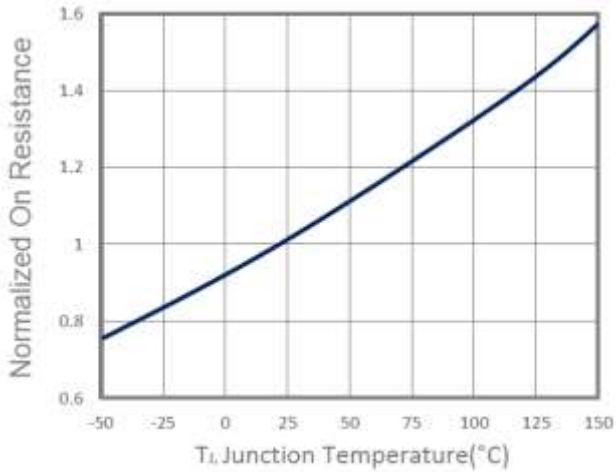


6. Power Dissipation

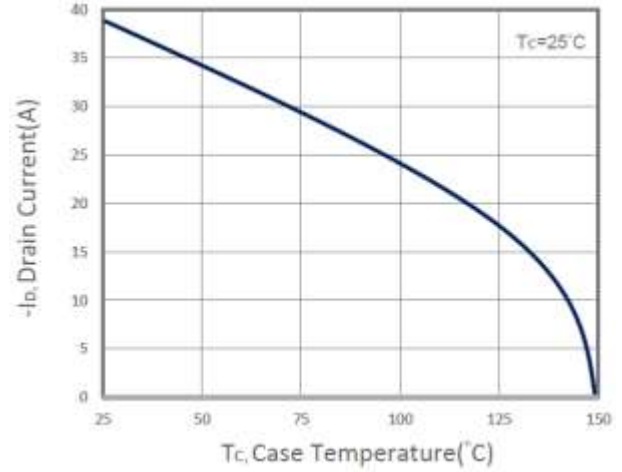




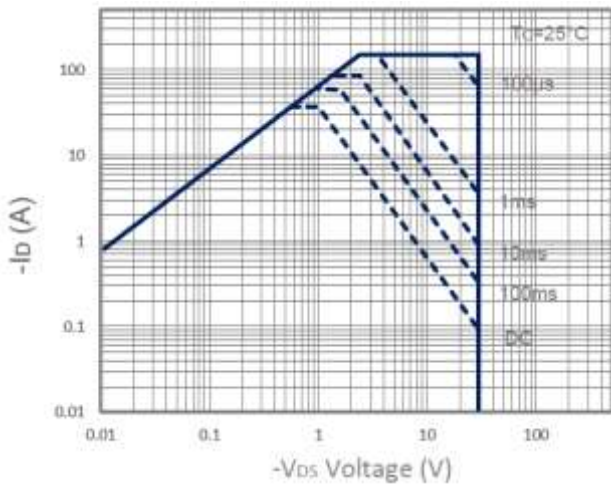
7.  $R_{DS(ON)}$  vs Junction Temperature



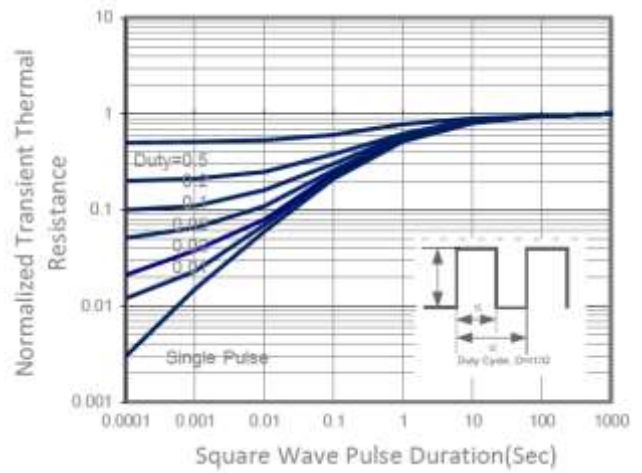
8. Drain Current vs. T<sub>C</sub>



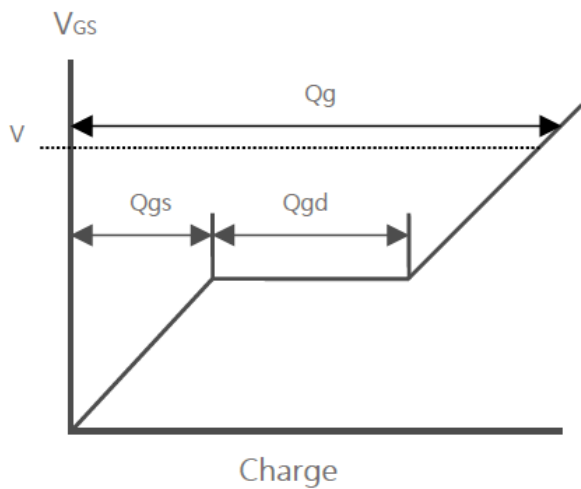
9. Maximum Safe Operation Area



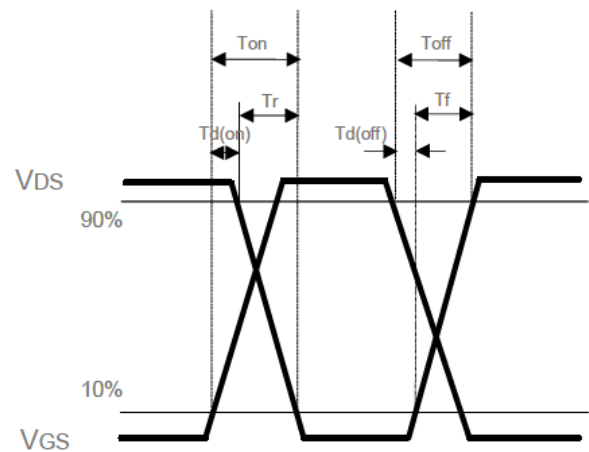
10. Thermal Transient Impedance



11. Gate Charge Waveform



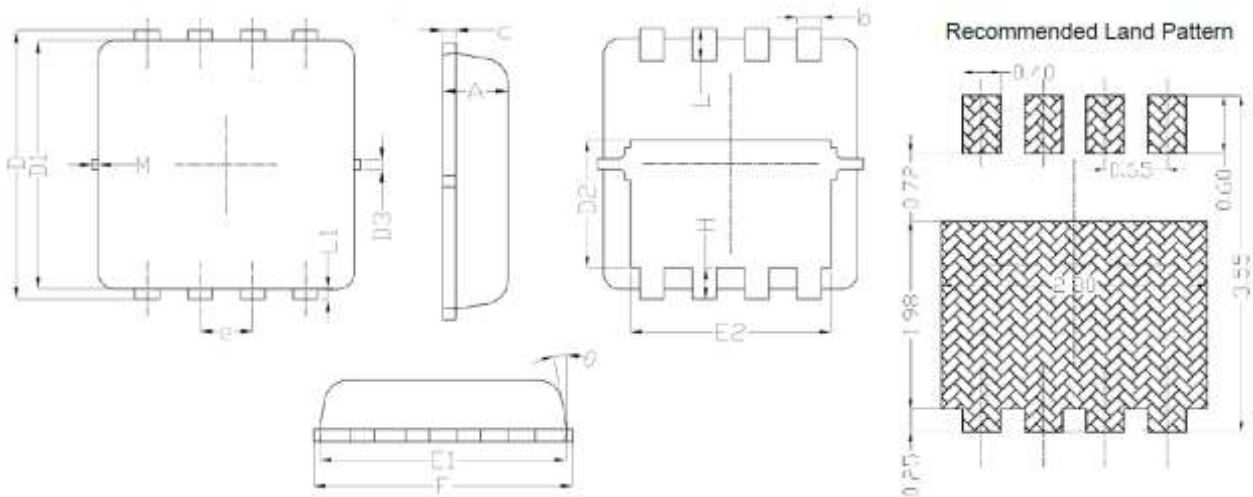
12. Switching Time Waveform





## PACKAGE INFORMATION

Dimension in DFN8(3.3x3.3) (Unit: mm)



Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.014
c	0.100	0.250	0.004	0.010
D	3.300	3.400	0.130	0.134
D1	3.250	3.450	0.128	0.136
D2	1.780	1.980	0.070	0.078
D3	-	0.130	-	0.005
E	3.200	3.400	0.126	0.134
E1	3.000	3.200	0.118	0.126
E2	2.390	2.590	0.094	0.102
e	0.650 BSC.		0.026 BSC.	
H	0.300	0.500	0.012	0.020
L	0.300	0.500	0.012	0.020
L1	-	0.130	-	0.005
M	-	0.150	-	0.006
θ	0°	12°	0°	15°



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